

P-Channel 60-V (D-S) MOSFET

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PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)		
-60	0.078 at V _{GS} = -10 V	-4.0	2.1 nC		
-00	$0.089 \text{ at V}_{GS} = -4.5 \text{ V}$	-3.1	2.1110		

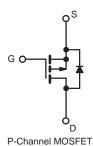
FEATURES

- TrenchFET II Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Battery Switch
- DC/DC Converter





Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	-60	V		
Gate-Source Voltage	V _{GS}	± 20			
	T _C = 25 °C		-4.0		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1_	-1.8		
Continuous Diain Curient (1) = 130 C)	T _A = 25 °C	I _D	-2.1 ^{b, c}		
	T _A = 70 °C		-1.5 ^{b, c}	A	
Pulsed Drain Current	I _{DM}	-16			
Continuous Courses Brain Binds Coursest	T _C = 25 °C	I.	-4		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	-0.91 ^{b, c}		
Avalanche Current	L = 0.1 mH	I _{AS}	-16		
Single-Pulse Avalanche Energy	L = 0.111111	E _{AS}	1.8	mJ	
	T _C = 25 °C		1.66		
Maximum Dayor Dissination	T _C = 70 °C	P _D	1.06	w	
Maximum Power Dissipation	T _A = 25 °C	' D	1.09 ^{b, c}	VV	
	T _A = 70 °C		0.7 ^{b, c}		
Operating Junction and Storage Temperature Range	•	T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	≤ 5 s	R _{thJA}	90	115	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	60	75		

Notes:

- a. Based on T_C = 25 °C. b. Surface Mounted on 1" x 1" FR4 board.
- d. Maximum under Steady State conditions is 120 °C/W.





MOSFET SPECIFICATIONS To Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{DS} = 0 V, I _D = -250 μA	-60			V	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-1		-3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Cata Valta na Duain Comunit	I _{DSS}	V _{DS} = -60 V, V _{GS} = 0 V			-1		
Zero Gate Voltage Drain Current		V _{DS} = -60 V, V _{GS} = 0 V, T _J = 55 °C			-10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -5 \text{ V}, V_{GS} = 10 \text{ V}$	-15			Α	
Davis Occurs Oc Otal D. 11 2		V _{GS} = -10 V, I _D = -1.9 A		0.078	0.095	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -1.7 \text{ A}$		0.089	0.115		
Forward Transconductance ^a	g _{fs}	V _{DS} = -15V, I _D = -1.9 A		5		S	
Dynamic ^b							
Input Capacitance	C _{iss}			650			
Output Capacitance	C _{oss}	\ \ _ 20.\\\\ 0.\\\\ 4.\\\\\\		102		pF	
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		23			
Total Gate Charge	0	V _{DS} = -30 V, V _{GS} = -10 V, I _D = -1.9 A		4.2			
	Qg			2.1		nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1.7 \text{ A}$		0.7			
Gate-Drain Charge	Q_{gd}			1			
Gate Resistance	R_g	f = 1 MHz		2.2		Ω	
Turn-On Delay Time	t _{d(on)}			4		- ns	
Rise Time	t _r	$V_{DD} = -30 \text{ V}, R_L = 20 \Omega$		10			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1.9 \text{ A}, V_{GEN} = -10 \text{ V}, R_G = 1 \Omega$		10			
Fall Time	t _f			7			
Turn-On Delay Time	t _{d(on)}			15			
Rise Time	t _r	$V_{DD} = -30 \text{ V}, R_L = 20 \Omega$		16		ns	
Turn-Off Delay Time	t _{d(off)}	$I_D = -1.7 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_G = 1 \Omega$		11			
Fall Time	t _f			11		<u>] </u>	
Drain-Source Body Diode Characteristic							
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			-4	Α	
Pulse Diode Forward Current ^a	I _{SM}				-16		
Body Diode Voltage	V_{SD}	I _S = -1.5 A		-0.8	-1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			15		ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = -1.5 A, dl/dt = 100 A/μs, T _J = 25 °C		10		nC	
Reverse Recovery Fall Time	t _a			12		nc	
Reverse Recovery Rise Time t _t		7		3		ns	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Notes: a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

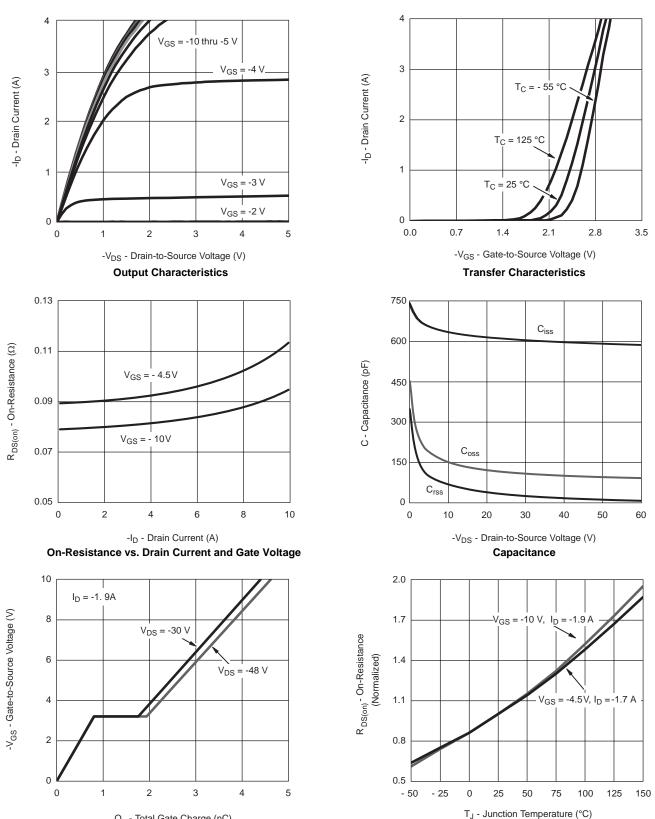


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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Q_g - Total Gate Charge (nC)

Gate Charge

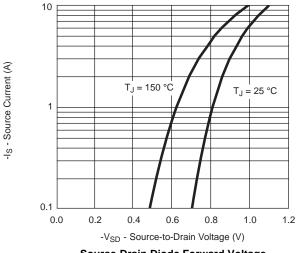


On-Resistance vs. Junction Temperature

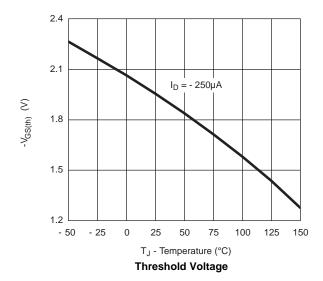


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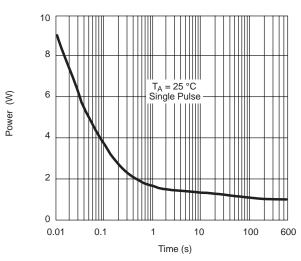


Source-Drain Diode Forward Voltage

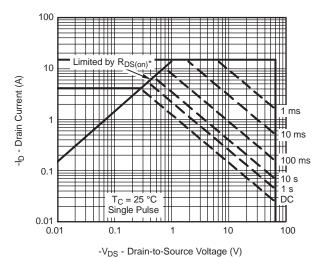


0.35 $I_D = -2.5 A$ 0.25 $R_{DS(on)}$ - On-Resistance (Ω) $T_J = 125 \, ^{\circ}C$ 0.20 0.15 T_J = 25 °C 0.10 0 6 10 -V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power

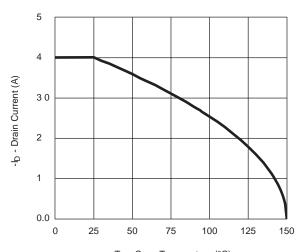


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

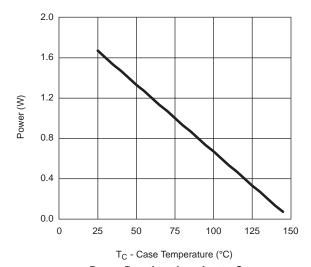


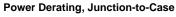
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

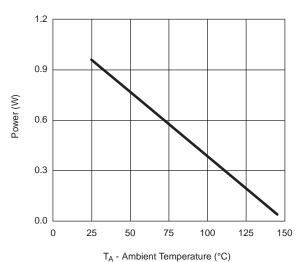


T_C - Case Temperature (°C)

Current Derating*





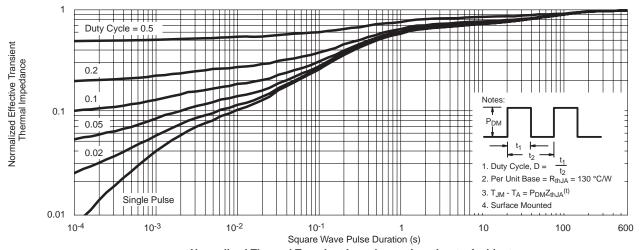


Power Derating, Junction-to-Ambient

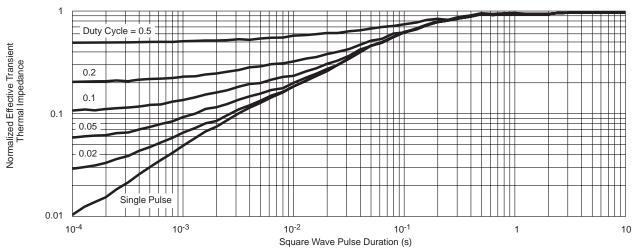
^{*} The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



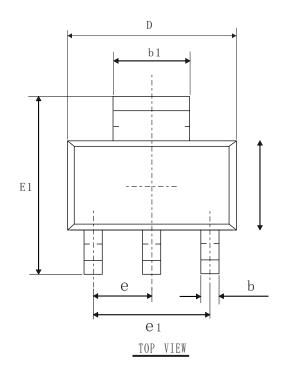
Normalized Thermal Transient Impedance, Junction-to-Ambient

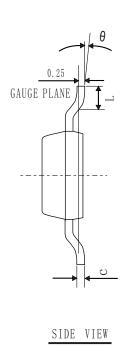


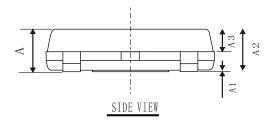
Normalized Thermal Transient Impedance, Junction-to-Foot



SOT-223-3L PACKAGE OUTLINE







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

MIN	TYP	MAX
,	-	1.95
0.00	0.05	0.16
1.35	1.60	1.85
0.65	0.90	1.15
0.55	0.70	0.90
2.75	3.00	3.30
0.18	0.30	0.42
6.00	6.50	7.00
3.10	3.50	3.90
6.50	7.00	7.50
4.20	4.60	5.00
0.78	-	1.28
0°	5°	10°
2.3BSC		
	- 0.00 1.35 0.65 0.55 2.75 0.18 6.00 3.10 6.50 4.20 0.78	





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